

**Search Notes**

Application/Control No.

10/719,758

Examiner

David Buttner

Applicant(s)/Patent under  
Reexamination

LEE ET AL.

Art Unit

1712

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
525	all	2/20/2007	DB
264	all	2/20/2007	DB

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	2/20/2007	DB